

Notice of References Cited	Application/Control No. 09/992,420	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
	Examiner Wen-Tai Lin	Art Unit 2154	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,760,745 B1	07-2004	Tan et al.	709/203
*	B	US-6,778,289 B1	08-2004	Iwata, Nobuo	358/1.15
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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